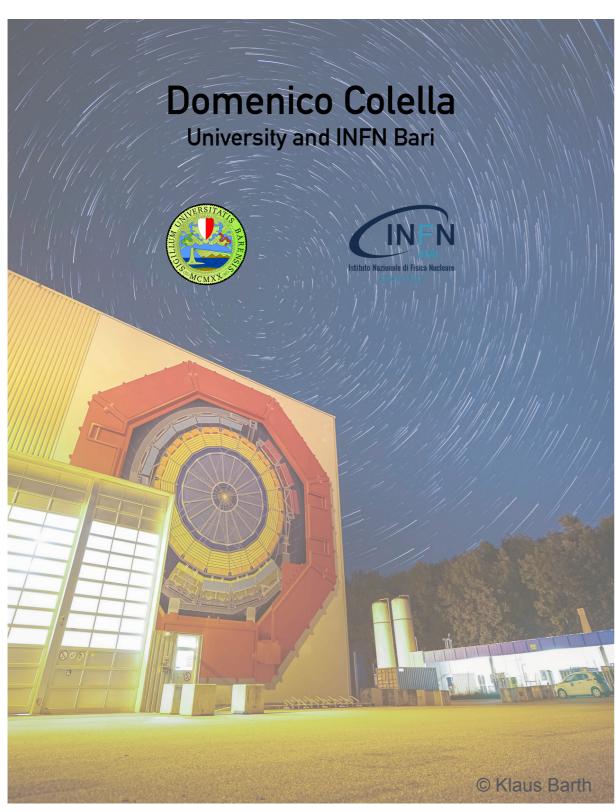
RD_FCC WP-Silicon Mini-workshop

Torino, 22-23 April 2024

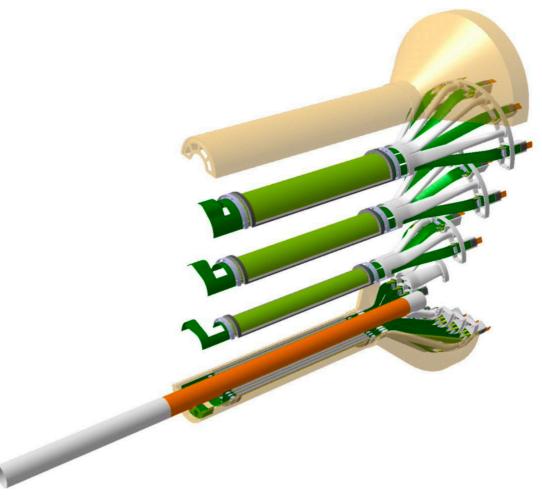




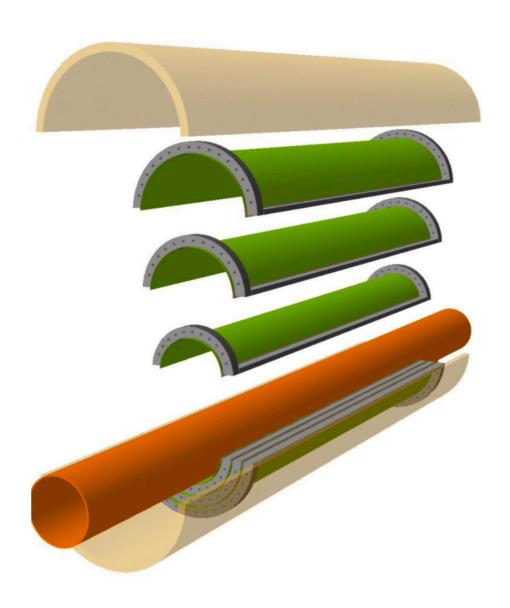
ALICE ITS3

how to integrate a large dimension MAPS sensor in a bent configuration detector

+ ALICE3

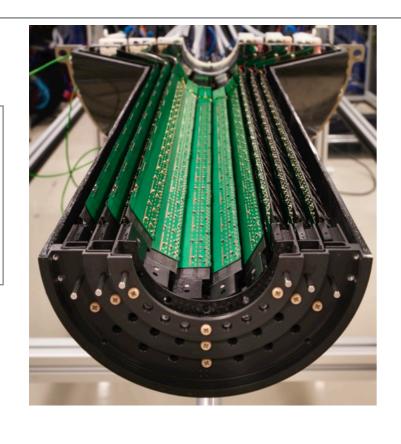


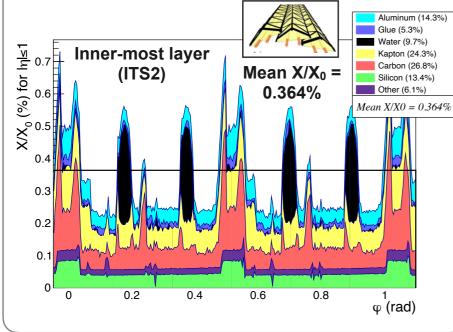






TS2-IB

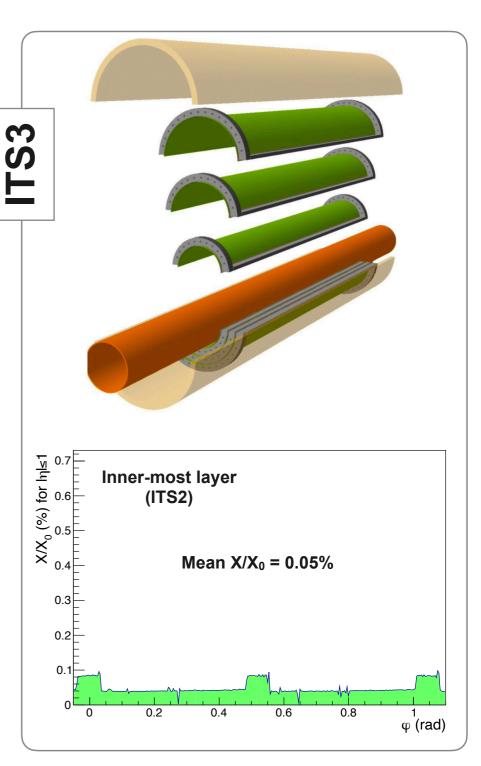






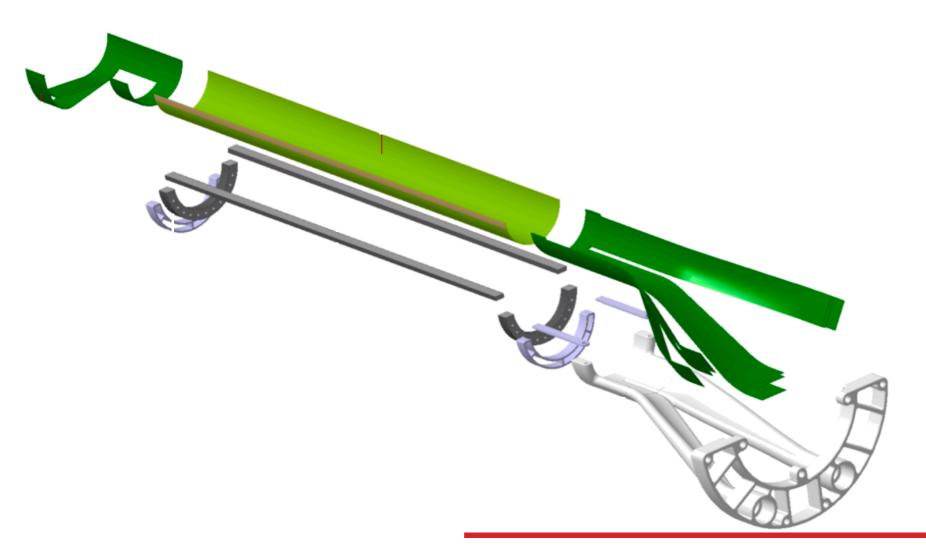
Required improvements

- » Removal of water cooling
 → low flow air cooling
- » <u>Removal of circuit board</u> from the sensitive region
- » Removal of mechanical support from the sensitive region, profiting from increased stiffness of bent Si wafers



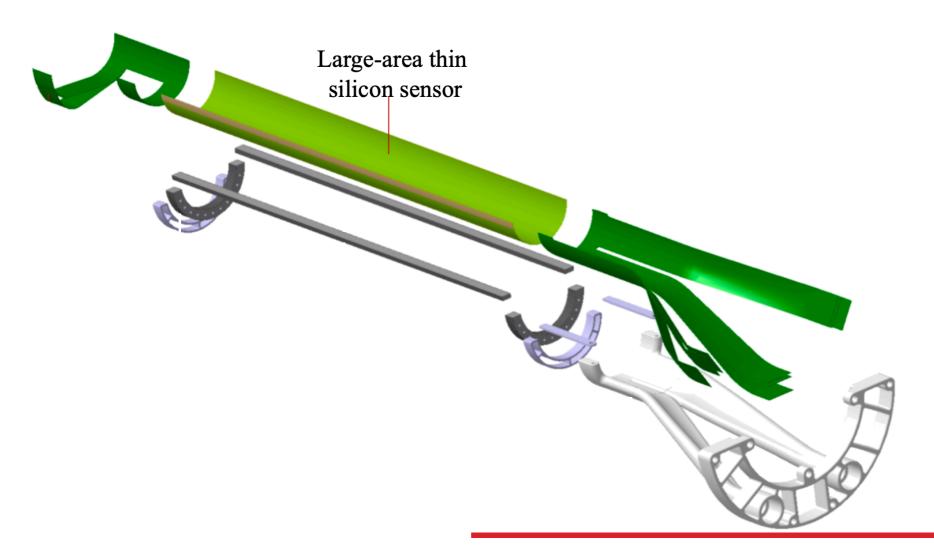


- » Wafer-scale chips (up to ~28x10 cm), fabricated using stitching
- » Si MAPS sensor based on 65 nm technology
- » Sensor thickness ≤ 50 µm
- » Chips bent in cylindrical shape at target radii
- » Ultra light carbon foam structures
- » Air cooling



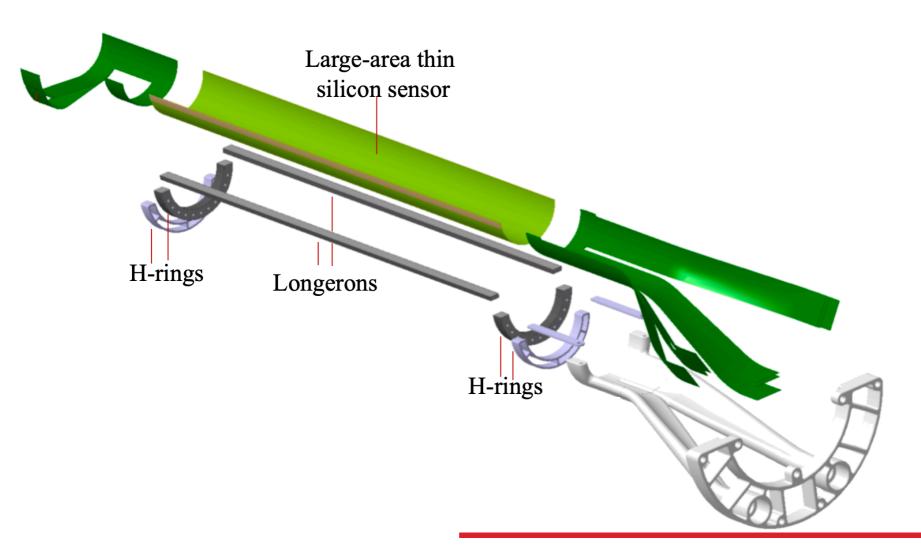


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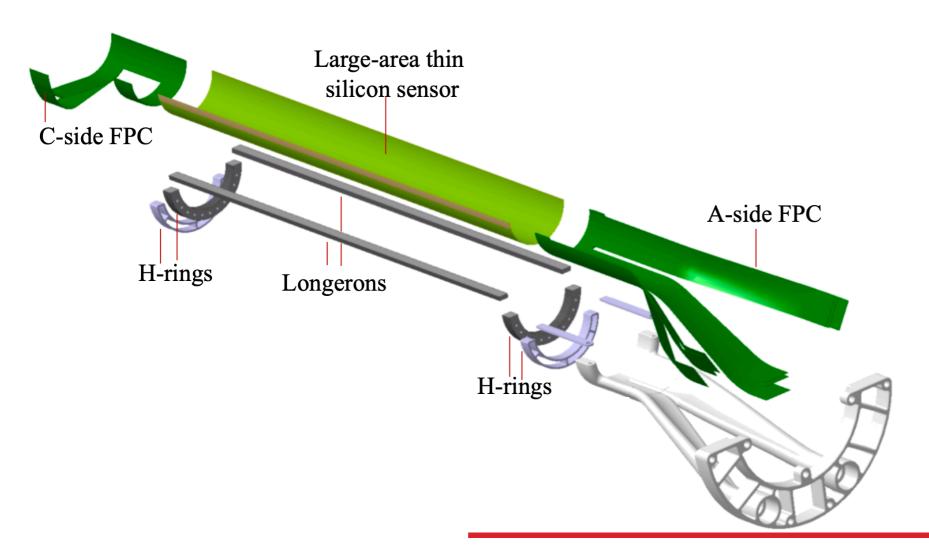


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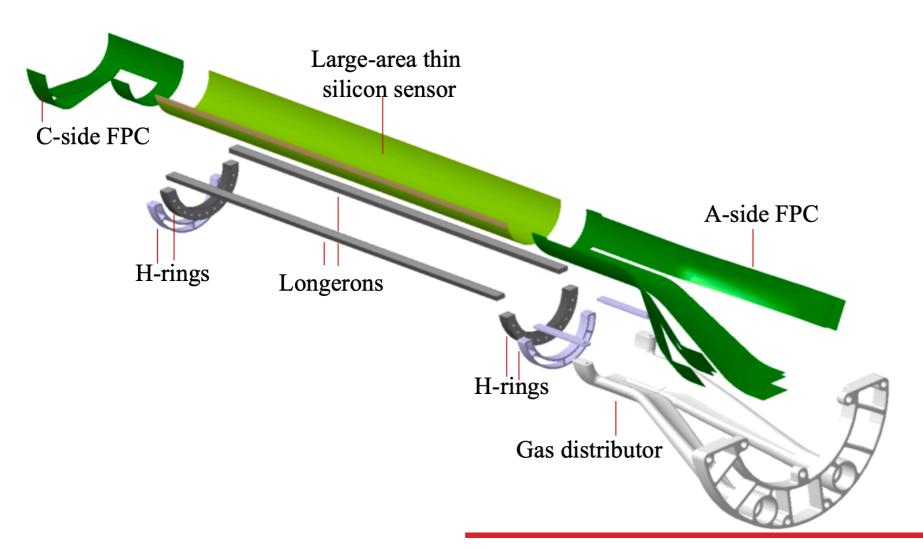


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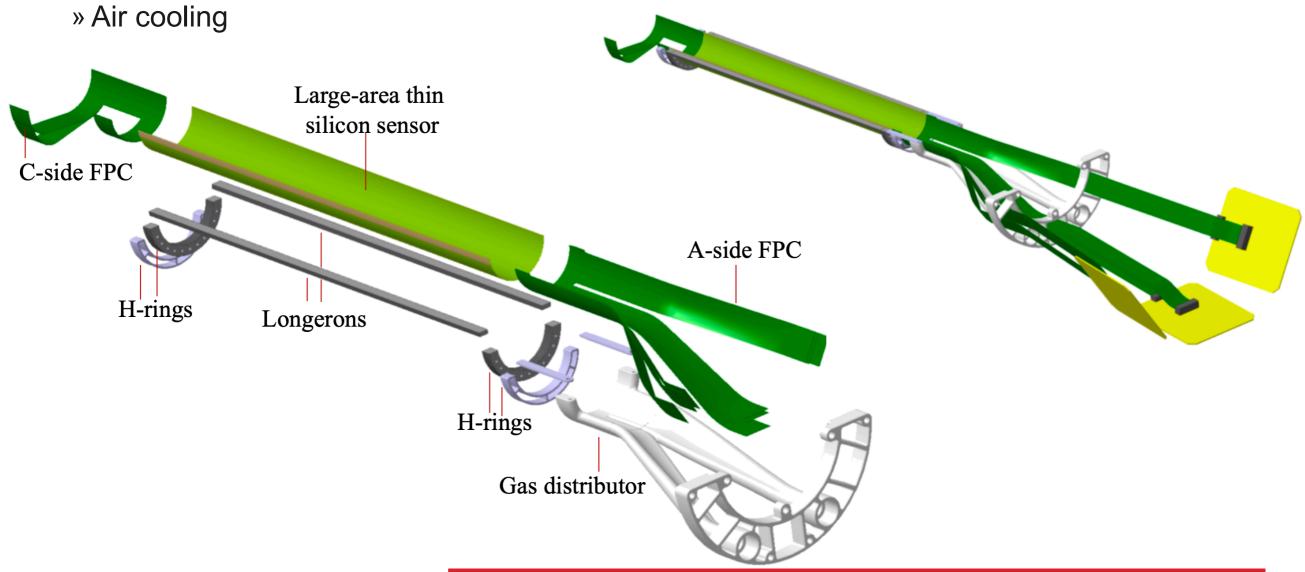


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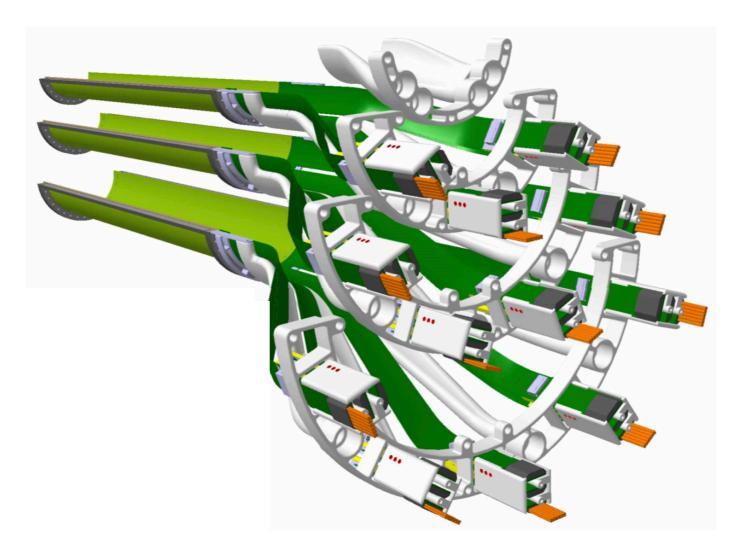


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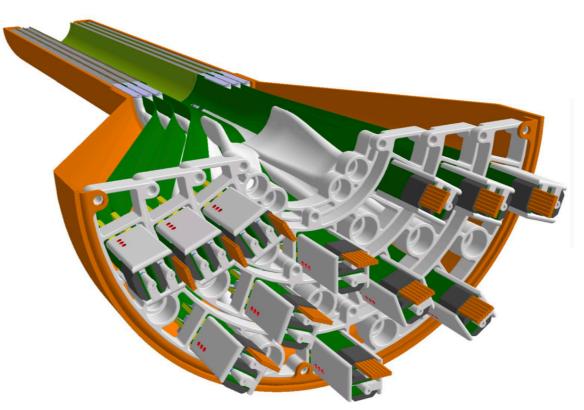




Key ingredients

- » Wafer-scale chips (up to ~28x10 cm), fabricated using stitching
- » Si MAPS sensor based on 65 nm technology
- » Sensor thickness ≤ 50 µm
- » Chips bent in cylindrical shape at target radii
- » Ultra light carbon foam structures
- » Air cooling

Beam pipe inner/outer radius (mm)	16.0/16.5					
IB Layer Parameters	Layer 0	Layer 1	Layer 2			
Radial position (mm)	18.0	24.0	30.0			
Length of sensitive area (mm)	280.0					
Pseudo-rapidity coverage	±2.5	±2.3	±2.0			
Active-area (cm²)	610	816	1016			
Pixel sensor dimension (mm²)	280 × 56.5	280 x 75.5	280 x 94			
Number of sensors per layer	2					
Pixel size (μm²)	O (10 x 10)					



The whole detector will comprise six chips and barely anything else!

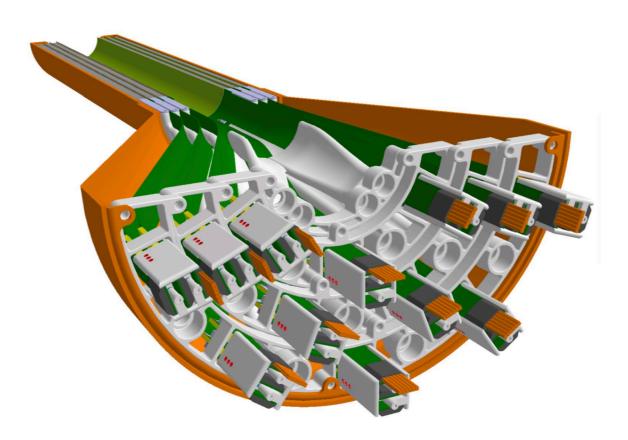


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This talk content:

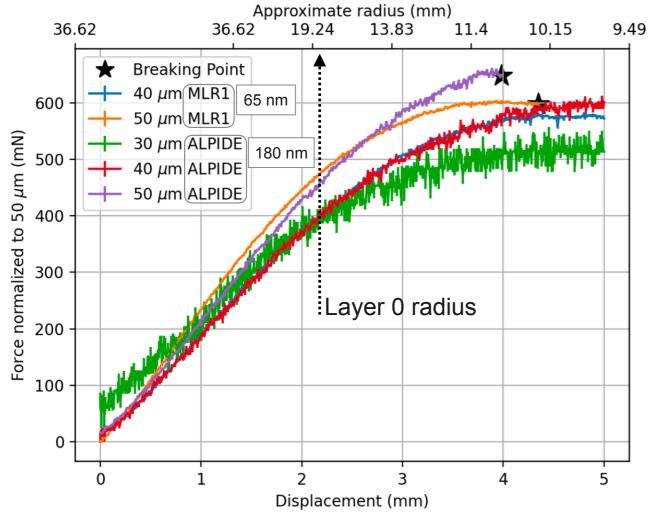
- → Silicon bending
- Carbon foam properties
- → Sensor cooling
- → Mechanical characterization
- **→** Interconnection

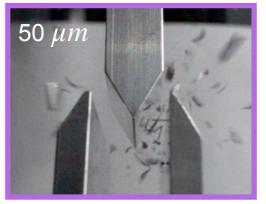


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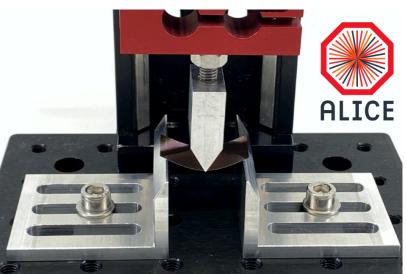


- » Three points bending force measurements:
 - MAPS ~50 µm thick are quite flexible
 - Large benefit from going thinner
 - Project goal thicknesses and desired bending radii achievable





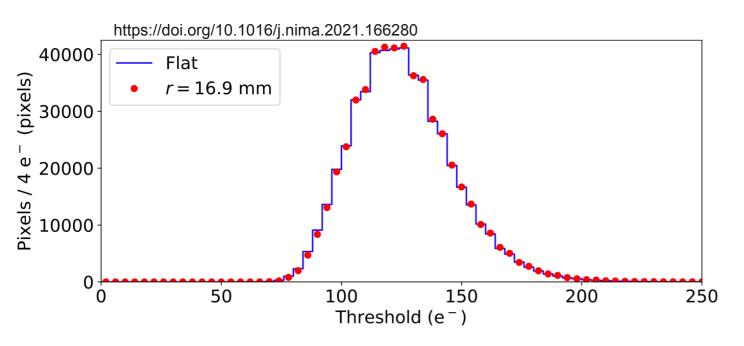


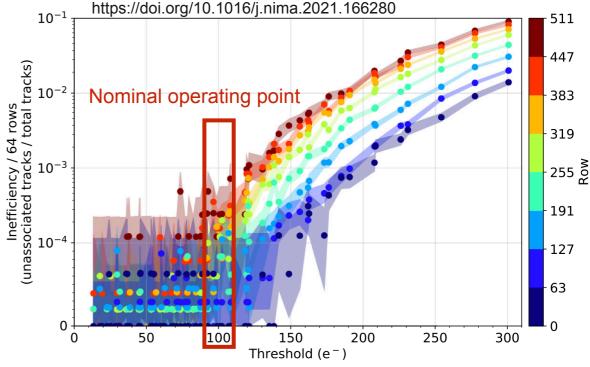






- Laboratory and test beam measurements (Jun 2020) allow to conclude that chip (180 nm CMOS) performance doesn't change after bending
 - Pixel matrix threshold distribution does not change when sensor is bent
 - Efficiency above 99.9% at a threshold of 100 e⁻

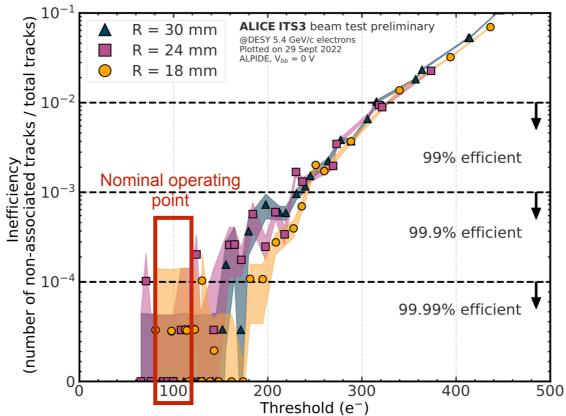






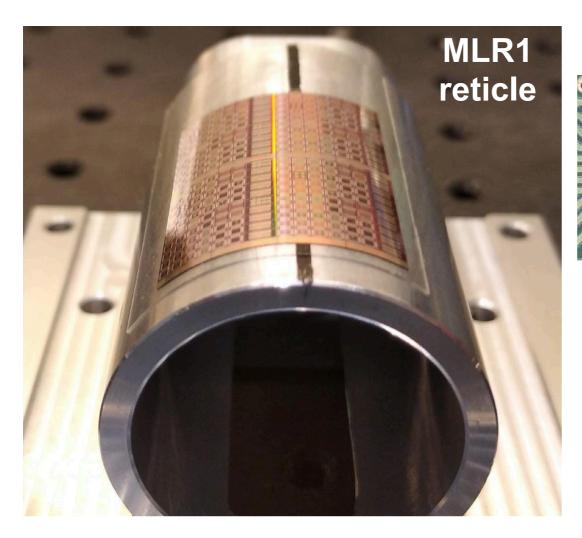


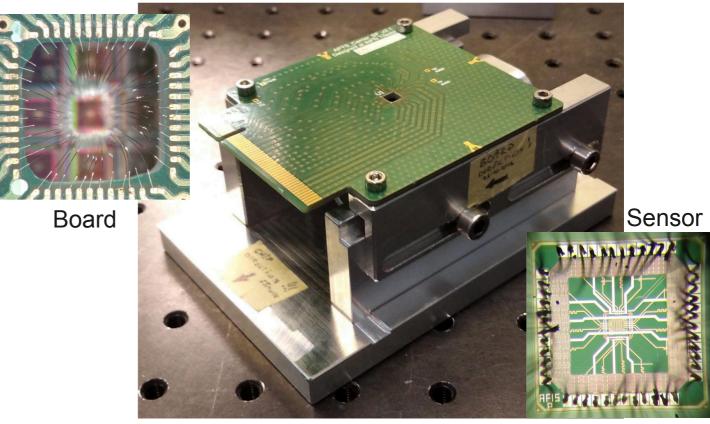
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Ongoing at INFN Trieste

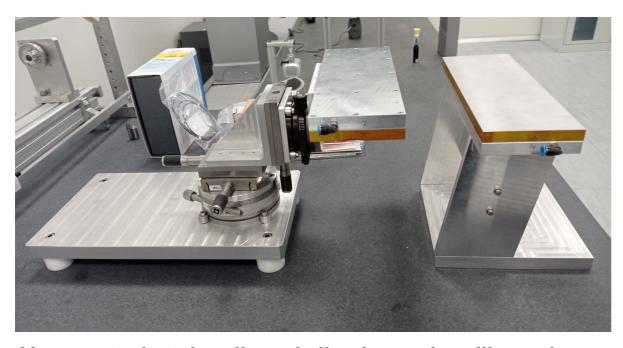
- » Comparison between flat and bent MLR1 (65 nm CMOS) sensors ongoing
 - · Bending procedure developed and proximity board adapted to bent configuration
 - Few samples prepared and under measurements in laboratory with 55Fe source



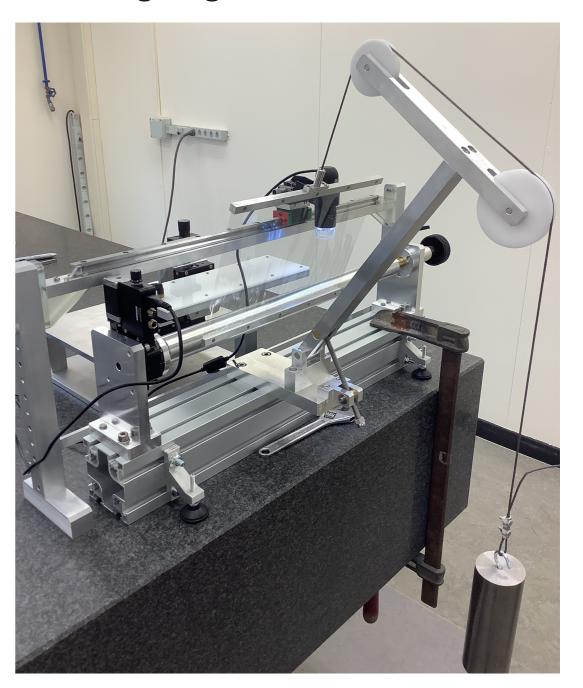


Ongoing at INFN Bari

- » Large dimension silicon bending procedure
 - Bending tool: tensioned mylar foil wrapping around cylindrical mandrel



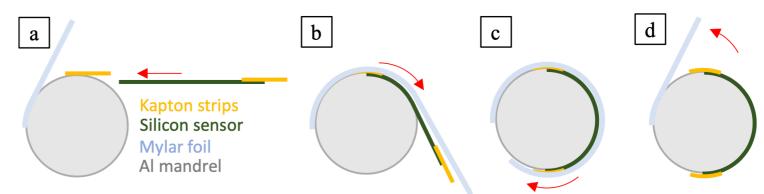
Vacuum tools to handle and align large-size silicon piece

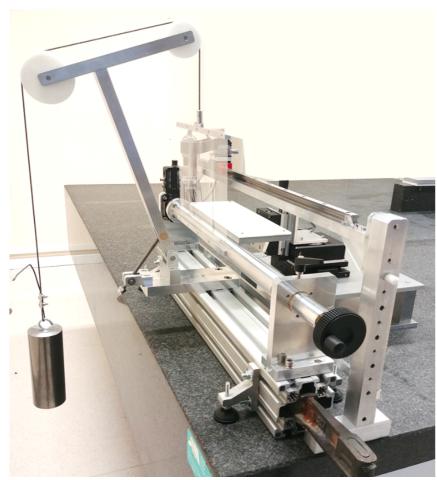


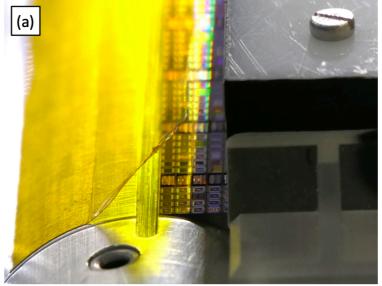
Bending tool equipped with: cylindrical mandrel, rotary motor, arm with weight to tension mylar foil, camera for alignment

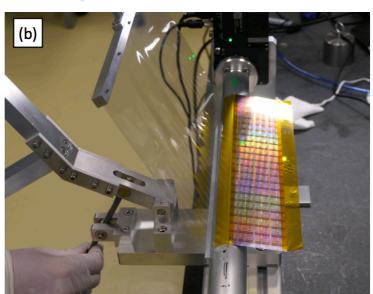
Ongoing at INFN Bari

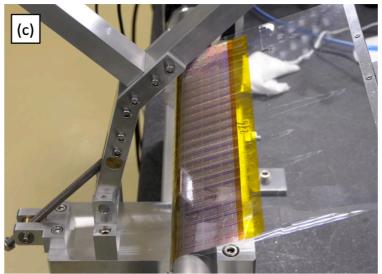
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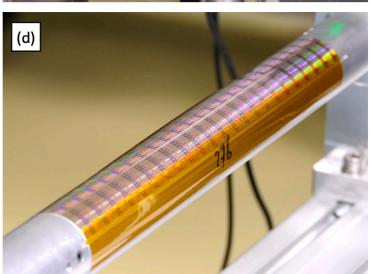






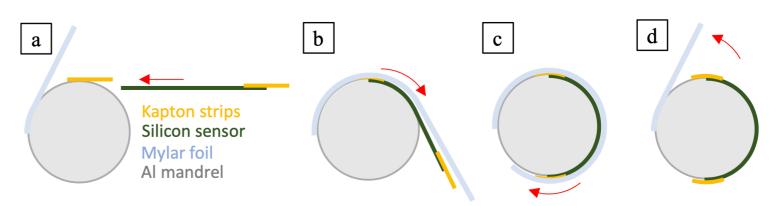


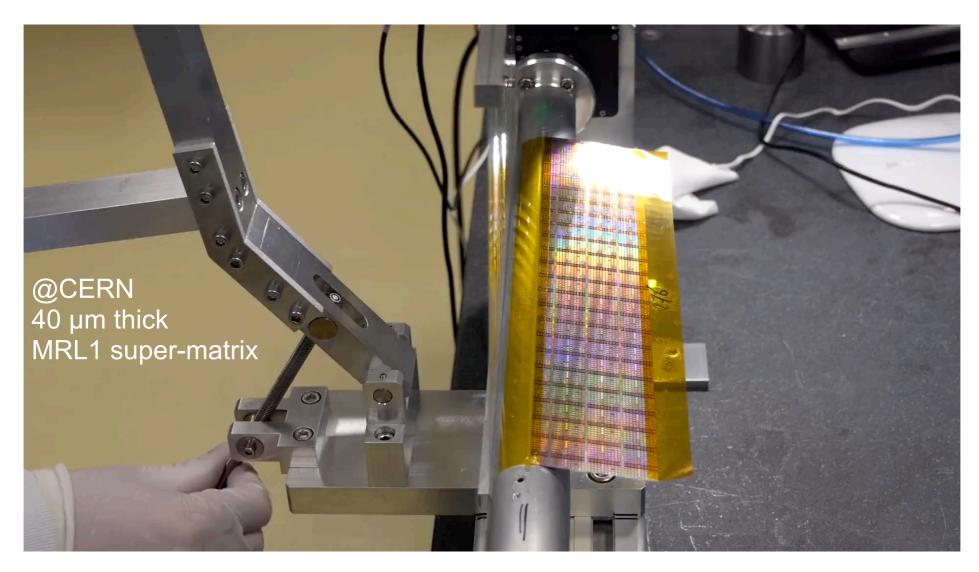




Ongoing at INFN Bari

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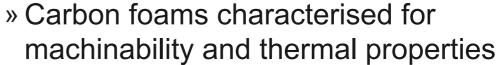
ITS3 R&D - Carbon foam properties



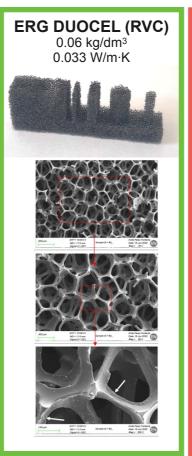
» Silicon sensor kept in position by:

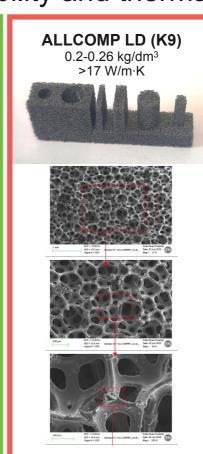


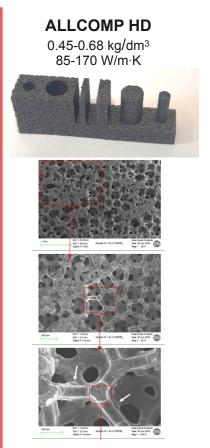








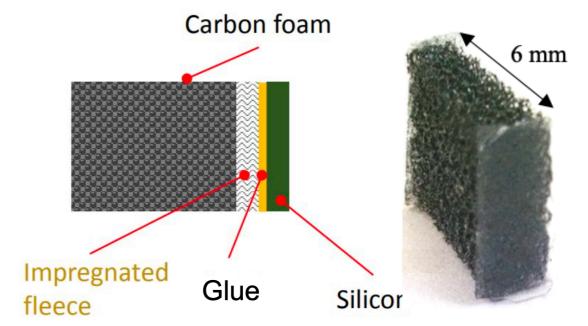




ITS3 R&D - Carbon foam properties

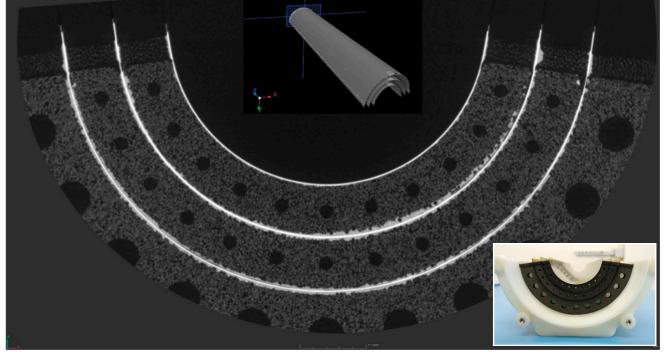


- » Carbon fleece veil (120 µm thick) between silicon and carbon foam used to:
 - Control the glue thickness
 - Reduce thermal contact resistance
 - Reduce carbon foam footprints on the silicon



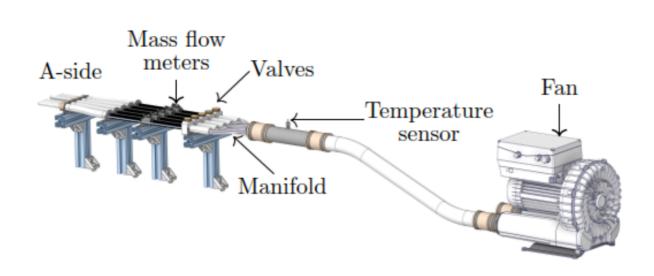
» Cylindricity granted within 0.05 mm using the half-ring

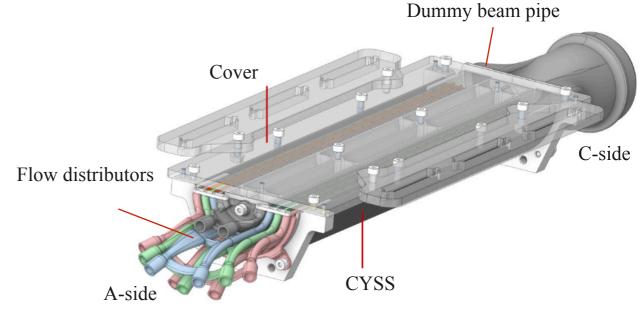
X-ray scan of Engineering Model 2 (EM2)

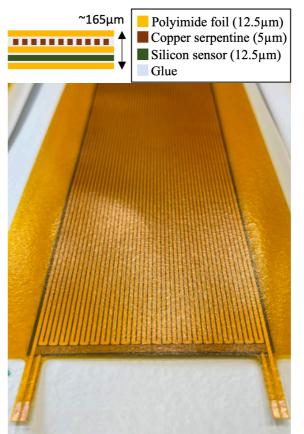


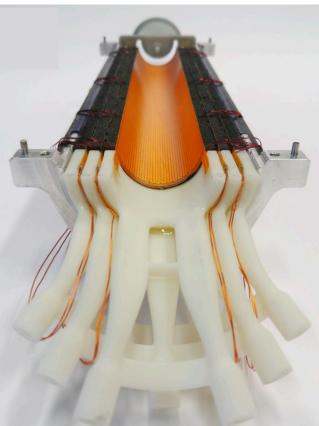
ITS3 R&D - Sensor cooling

- » Thermal characterization setup
 - dummy silicon equipped with copper serpentine simulating heat dissipation in matrix (25 mW/cm²) and end-cap (1000 mW/cm²) regions
 - 8 PT100 temperature sensors distributed over the surface of each half-layer
 - <u>airflow</u> from A-side to C-side



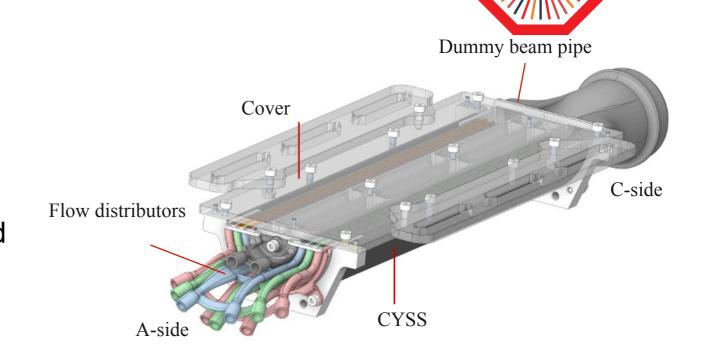


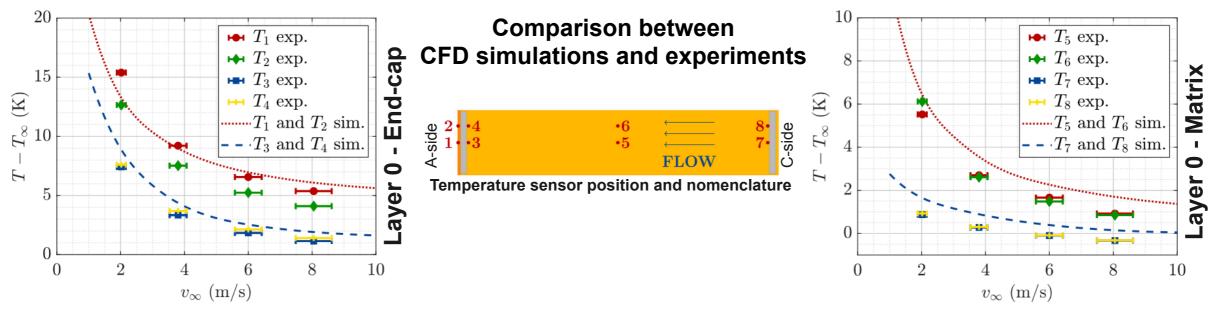




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» Conclusion

- with an average airflow free-stream velocity between the layers of about 8 m/s, the detector can be operated at a temperature of 5 degrees above the inlet air temperature
- temperature uniformity along the sensor can be also kept within 5 degrees

ITS3 R&D - Mechanical characterization



- » Short-term position stability of the sensor over time affected by
 - thermoelastic expansion caused by short-term temperature fluctuation
 - airflow

ITS3 R&D - Mechanical characterization



- » Short-term position stability of the sensor over time affected by
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» Thermoelastic expansion setup

- differential thermoplastic expansion among different components could introduce failures
- final grade material half-layer assembly in climate chamber (up to 36°C by steps of 2 °C)



Materials

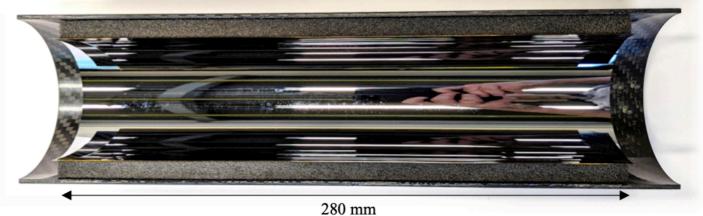
C-side H-ring: carbon foam, ERG (RVC) Duocel®

Longerons: carbon foam, ERG (RVC) Duocel®

Half-layer 2: Blank silicon 40 μm

CYSS: carbon sandwich

A-side H-ring: carbon foam, Allcomp k9 SD



» Conclusion

- several thermal cycles for a total of 9h → assembly unaffected
- further tests will be performed to investigate: rapid increase of the temperature and maximum failure temperature

ITS3 R&D - Mechanical characterization

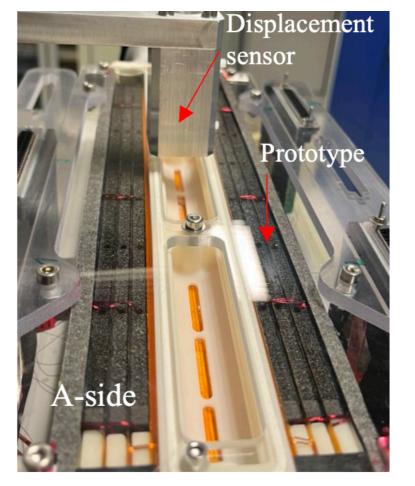


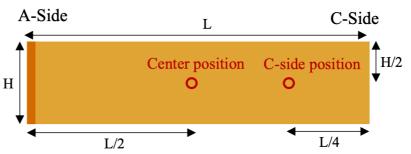
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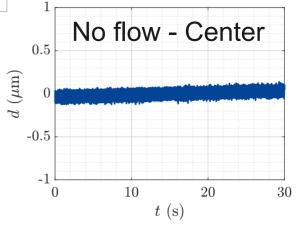
- » Vibration characterization setup
 - measurement of the out-of-plane vibrations of the half-layers
 - confocal chromatic displacement sensors → avoids perturbation to the airflow

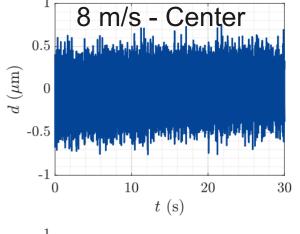
» Conclusion

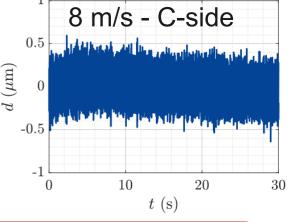
• RMS_{airflow} < 0.4 μm for L2 (largest sensor), smaller for L0 and L1









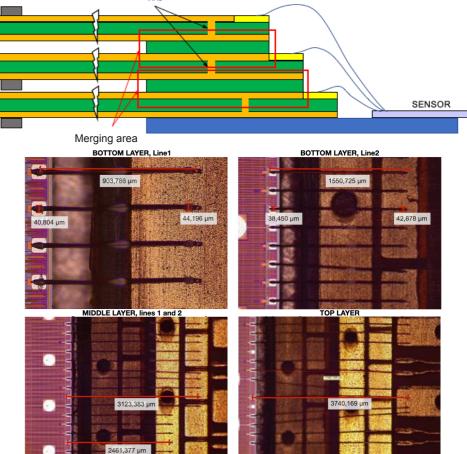


ITS3 R&D - Interconnection

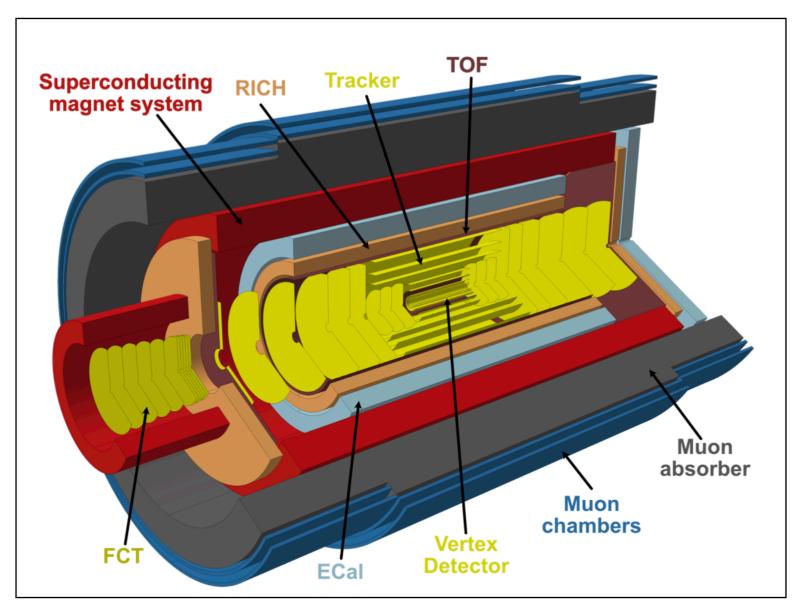


- » Flexible printed circuits for communication and powering
 - placed outside the sensible area
 - three double copper layers flex, multi-strip shaped (15-30 cm long), connected in a merging area
 - interconnected via wire-bonding at the edge of the sensor verified
 - wire-bonds loops optimisation based on pull-force measurements
 - present setup (not final grade material): 6.6±0.3 g at ~900 μm pad-to-pad distance





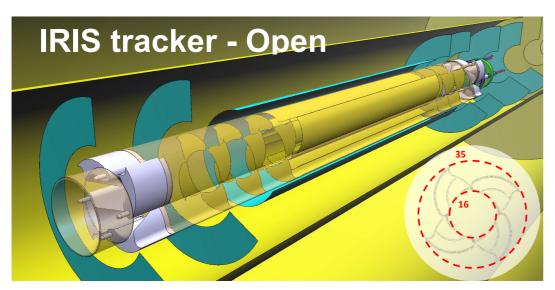


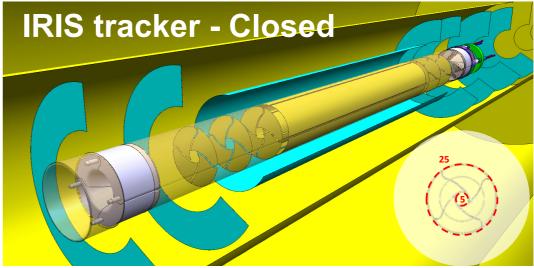


ALICE3: a silicon sensor based experiment

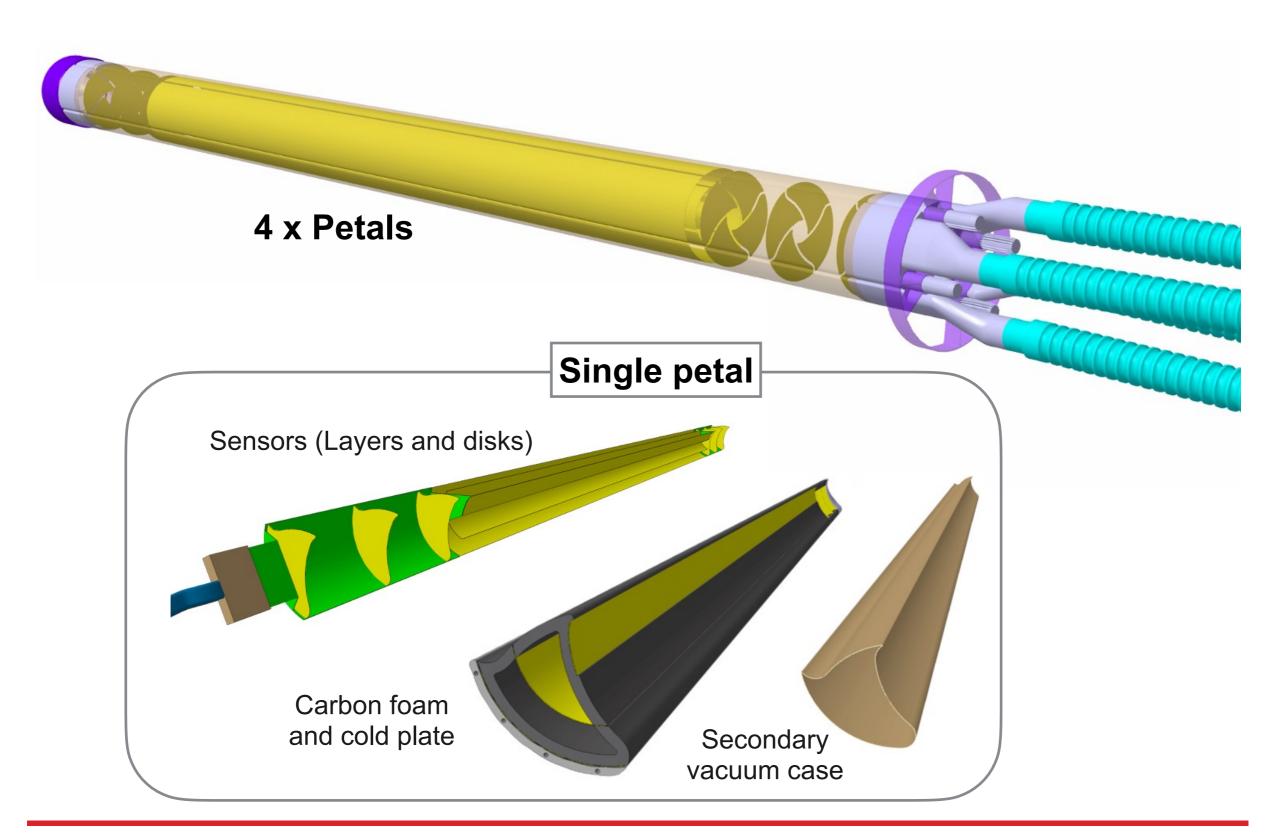


- » Based on wafer-scale, ultra-thin, curved MAPS
- » Basic requirements
 - radial distance from interaction point: 5 mm (inside beam pipe, retractible configuration)
 - unprecedented spatial resolution: ≈ 2.5 µm
 - unprecedented low material budget X/X₀ (per layer): ≤ 0.1%
 - radiation tolerance: ≈ 10¹⁶ 1 MeV n_{eq}/cm² + 200 Mrad
 - hit rates up to: 94 MHz/cm²
- » R&D will largely leverage on the ITS3 developments and push improvements on a number of fronts

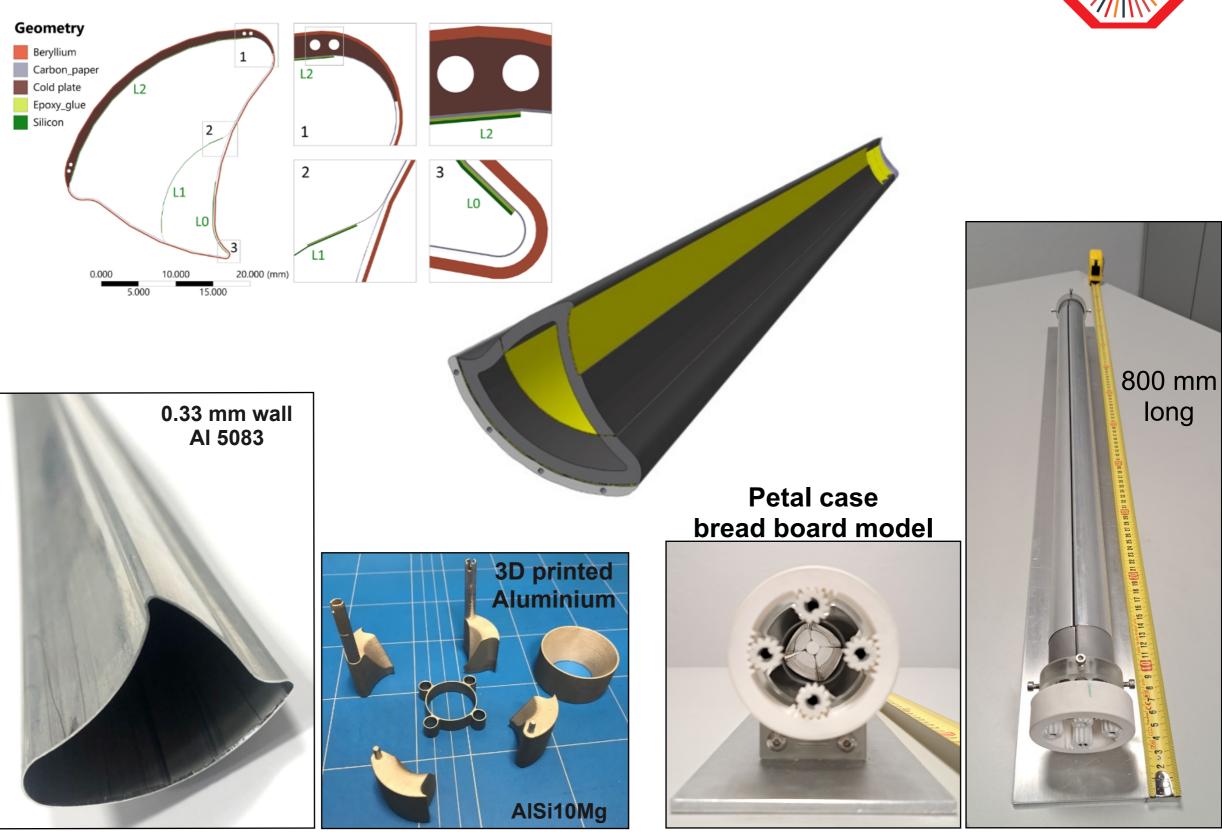








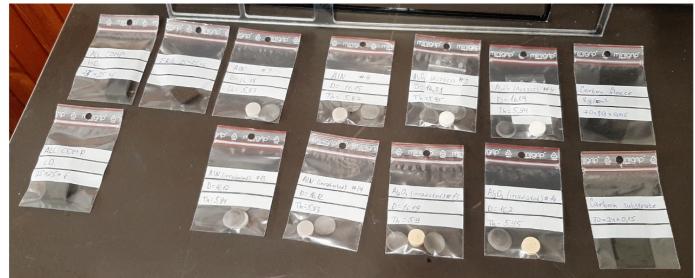


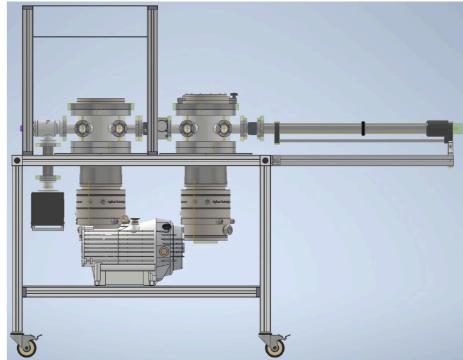


Outgassing studies at INFN Bari

- Carbon (LAYPUS) Substrate of the cold plate
- Carbon Fleece of the cold plate
- Carbon foam All comp high density
- Carbon foam All comp low density
- Carbon foam ERG duocel
- Optical Fiber with connector
- NASA Epoxy
- Si wafer
- Wire bonded Si wafer
- FPC
- 3D printed aluminium nitride (AIN) samples disks
- Al2O3 samples disk: 3D printed alumina (Al₂O₃) samples disks
- 3D printed AlSi samples disks



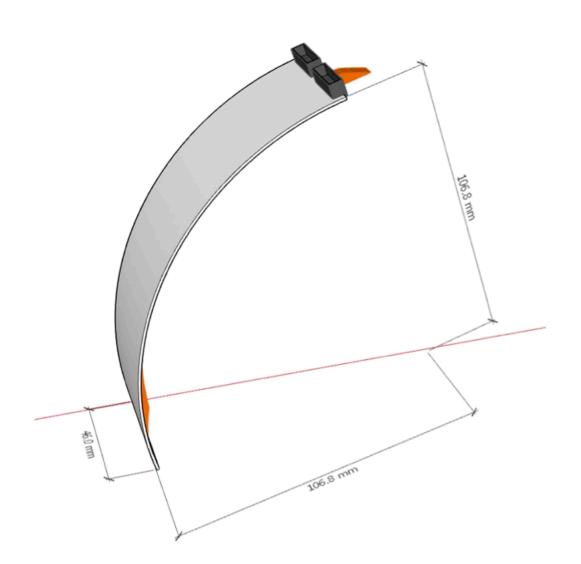




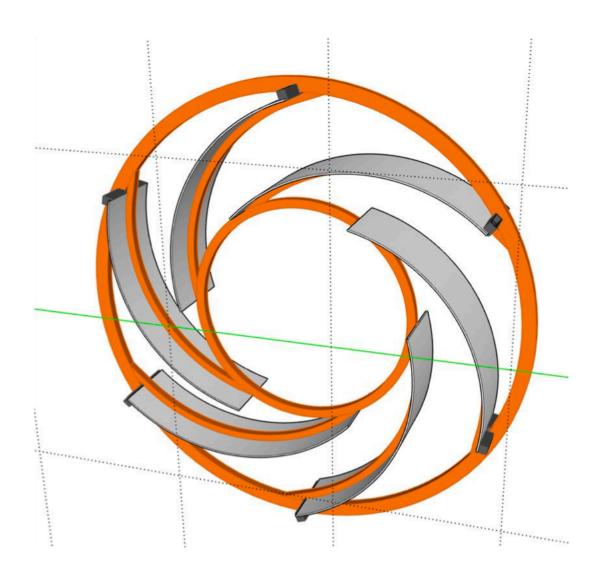


Prototype by INFN Padova

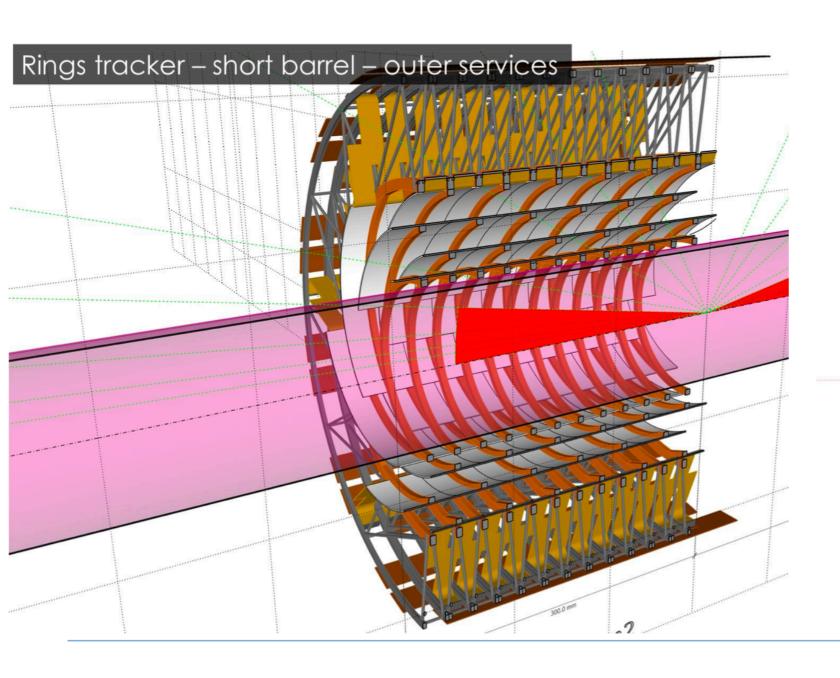
Modular unit - blade



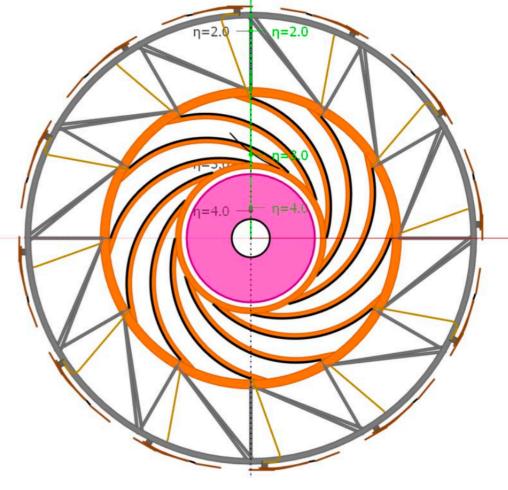
Modular unit - wheel



Prototype by INFN Padova

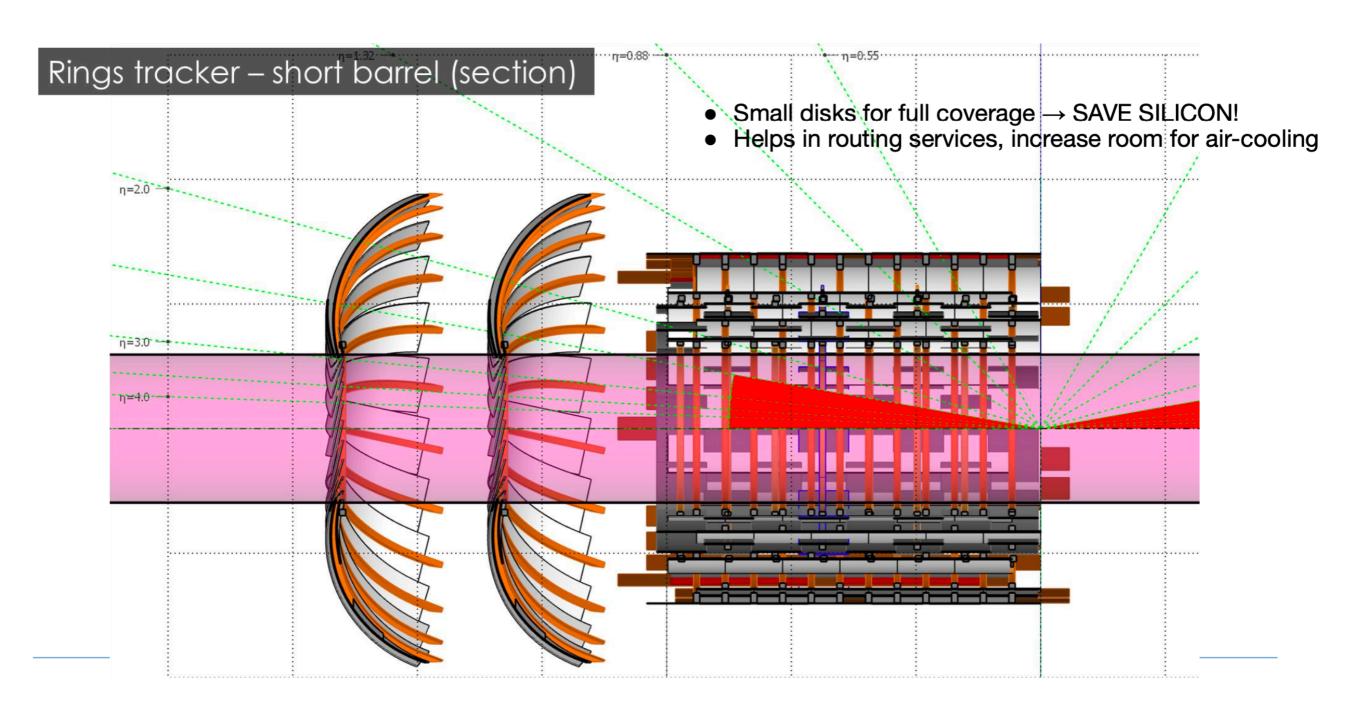


- Power from outer radii concept
- Air-cooling "friendly" structure

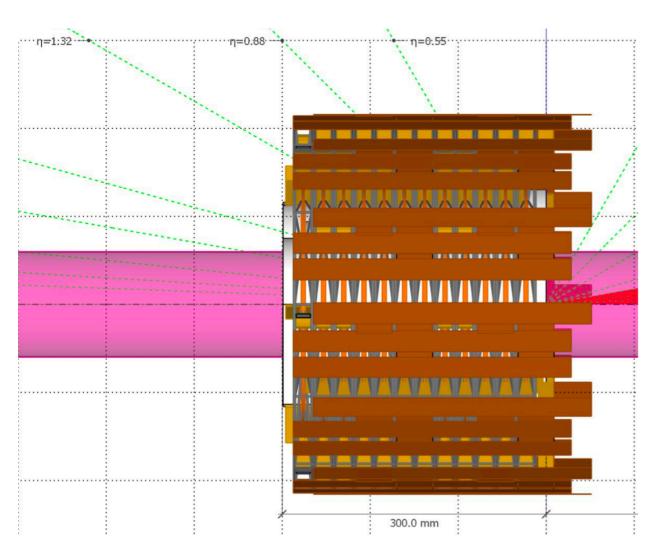




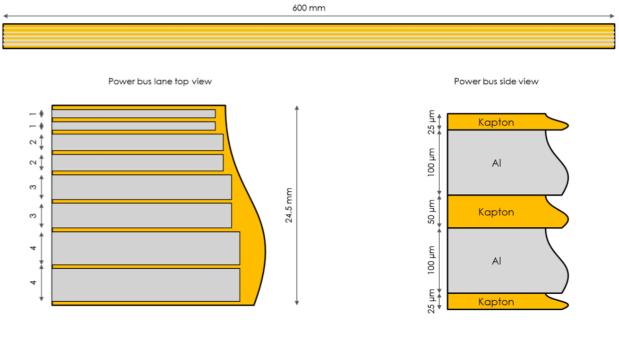
Prototype by INFN Padova



Prototype by INFN Padova



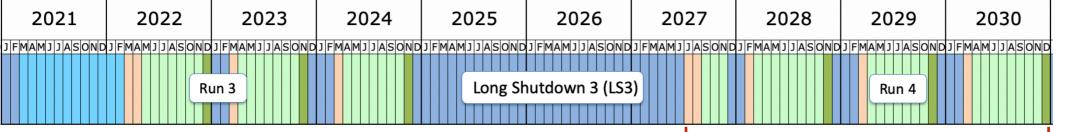
- Power bus studied for PARALLEL powering (so far)
- SERIAL powering will further reduce material (to do)



Backup



Backup







Expression of Interest



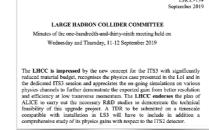
[ALICE-PUBLIC-2018-013] https://cds.cern.ch/record/2644611

Letter of Intent



[CERN-LHCC-2019-018; LHCC-I-034] https://cds.cern.ch/record/2703140/

LHCC 139 (Sep 2019)



"The LHCC is **impressed** by the new concept for the ITS3..."

ALICE 2.1

Project setup (spring 2020)

- Project leaders
- Work packages conveners
- Institutes joining

LHCC 142 (Jun 2020)



The LHCC congratulates the ITS3 groups for the successful start of the project

"The LHCC congratulates the ITS3 groups for the successful

start of the project."

Sep 2019 Oct 2018

Sep 2019

Dec 2019

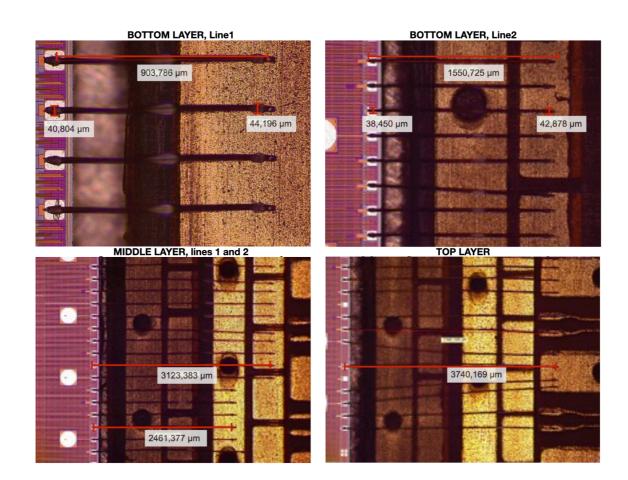
R&D kick-off (Dec 2019)

Spring 2020

Jun 2020

Backup - Interconnection





Line	BOT-L1	BOT-L2	MID-L1	MID-L2	TOP-L1
Loop height (μm)	110	220	310	360	500
Pad-pad distance (µm)	880	1520	2420	3140	3740
Wire angle on FPC (°)	13	15	17	8	4
Wire angle on sensor (°)	12	16	14	13	15
Pull force (g) [mean ± dispersion]	6.6 ± 0.3	6.6 ± 0.3	5.1 ± 0.4	5.2 ± 0.3	3.8 ± 0.3
Pull force (g) [min - max]	5.8-7.0	6.2 - 7.1	4.3 - 5.7	4.7 - 5.6	3.2-4.2
Force on wire FPC side (g)	15.3	12.3	13.8	14.1	11.3
Force on wire sensor side (g)	15.2	12.4	14.1	14.4	11.6

Backup - Super-ALPIDE project

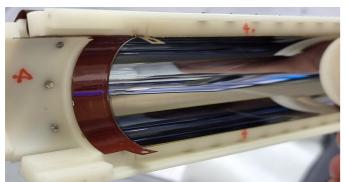


» Super-ALPIDE

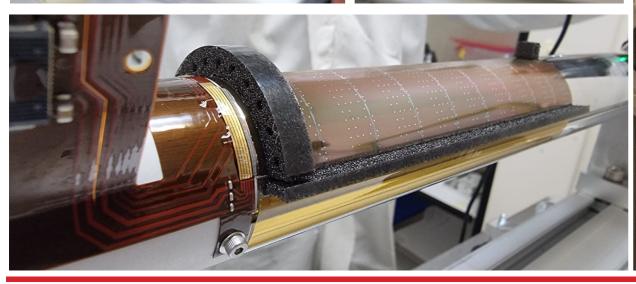
- 18 not diced ALPIDE chips
- dimensions close to the ones for L0 sensor

» Goals

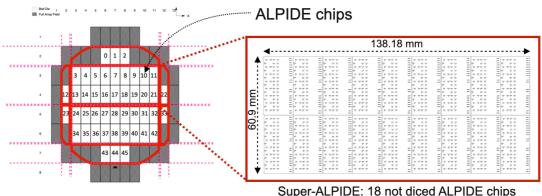
- verify bending tools for large-size working chips
- verify mechanical support alignment tools
- develop wire-bonding over bent surface tools
- develop first bent flex prototype (for powering and data streaming)
- assemble first working large dimension bent sensor → by October 2023





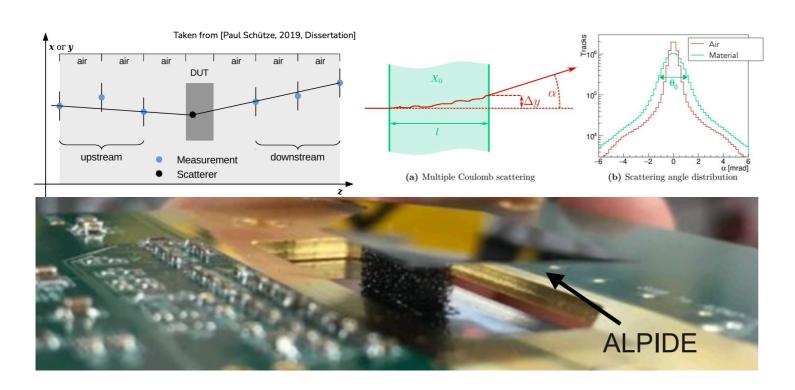




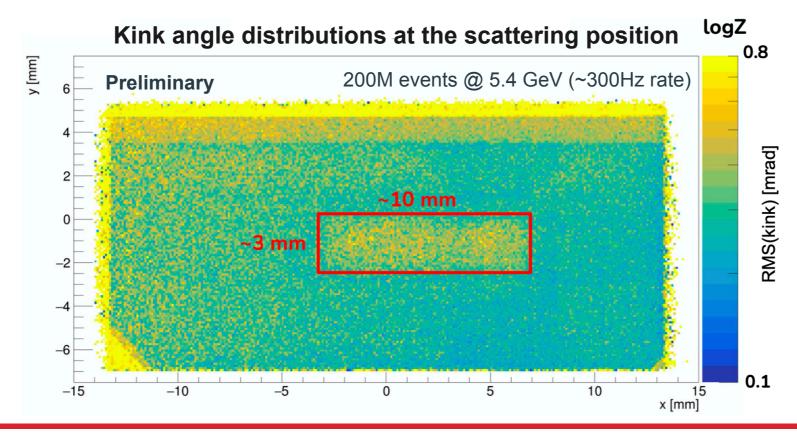


Backup - Carbon foam properties





» Carbon foam material budget study though particle deviation angle measurement



Backup - Carbon foam properties



Iris tracker: Petals Cooling @~-25°C

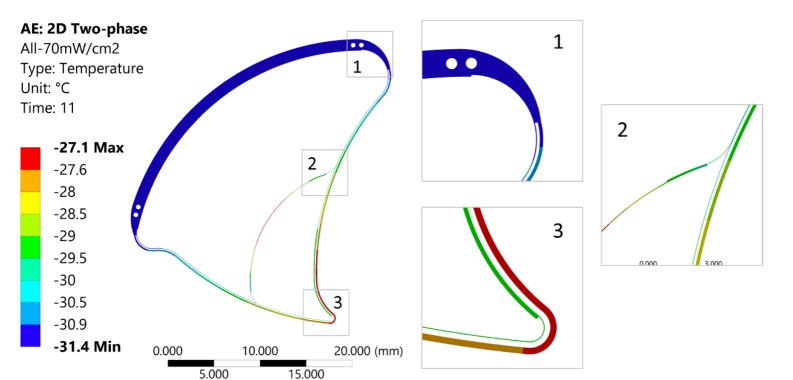
Expected 1x10^16 1 MeV n_eq of NIEL in 50 months of operation and 6 Mrad TID. Cooling will mitigate leakage current damages that will also depend on the process and the pixel geometry, not yet defined, in addition to the NIEL radiation level. The NIEL radiation load is about the same as for ATLAS and CMS.

Design assumption for preliminary assessment

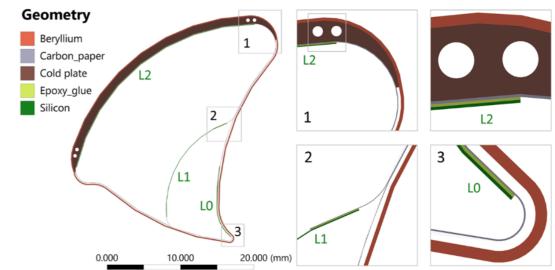
- Two-phase evaporative CO2

 (alternatives fluid will be considered)
- 2. Applied heat flux

70mW/cm2 sensors heat flux 100mW/cm2 beam pipe current flow (impedance)



Temperature profile



Preliminary results show that the sensors can be cooled at ~ -29C with an inlet CO2 at -35C.

Same analysis also shows a <u>deltaT</u> of 1-2 degrees within the single sensor and 5 degrees between the coldest (outermost) and hottest sensor (innermost).